

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT  <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO.	SERIAL NO.
	59349.00031	10/540,470
	APPLICANT Naohide OGAWA, et al.	
	FILING DATE	GROUP
	June 23, 2005	

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

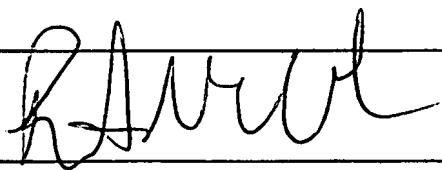
## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
RM	AG	2001-150374	June 5, 2001	JAPAN					X
	AH	11-048170	February 23, 1999	JAPAN					X
	AI	2002-144260	May 21, 2002	JAPAN					X
RW	AJ	06-114766	April 26, 1994	JAPAN					X
	AK								

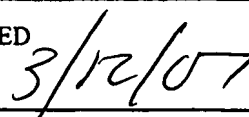
## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL	
	AM	
	AN	

EXAMINER



DATE CONSIDERED



\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 59349.00031	10/540470 New Application
LIST OF REFERENCES CITED BY APPLICANT  (Use several sheets if necessary)		APPLICANT OGAWA et al	
		FILING DATE June 23, 2005	GROUP Not yet assigned

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
<i>W</i>	AA	6,064,167	05/16/00	Takenaka et al			
	AB						
	AC						
	AD						
	AE						
	AF						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO PART.
	AG	JP 2002-144260	05/21/02	Japan				
	AH	EP 1103449 A1	05/30/01	European				
	AI	JP 7-334227 A	12/22/95	Japan				
	AJ	JP 2003-274163	10/09/01	Japan				
	AK							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL	
	AM	
	AN	
EXAMINER	<i>[Signature]</i>	DATE CONSIDERED 3/12/05

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.